

Maximum Ratings (@ $T_A = +25^{\circ}C$, unless otherwise specified.)

Characteristic	Symbol	Value	Units		
Drain-Source Voltage	V_{DSS}	60	V		
Gate-Source Voltage			V _{GSS}	±20	V
Continuous Dusin Coursest (Note CVV 40V	Steady State	$T_A = +25^{\circ}C$ $T_A = +70^{\circ}C$	I _D	5.0 4.0	А
Continuous Drain Current (Note 6) V _{GS} = 10V	t < 10s	$T_A = +25^{\circ}C$ $T_A = +70^{\circ}C$	I _D	7.1 5.5	А
Pulsed Drain Current (10µs Pulse, Duty Cycle = 1%)	I _{DM}	30	Α		
Maximum Body Diode Continuous Current	Is	3.4	Α		
Avalanche Current (Note 7) L = 0.1mH	I _{AS}	14.2	Α		
Avalanche Energy (Note 7) L = 0.1mH			Eas	10	mJ

Thermal Characteristics (@T_A = +25°C, unless otherwise specified.)

Characteristic		Symbol	Value	Units
Total Bower Dissipation (Note 5)	TA = +25°C	C	1.2	- W
Total Power Dissipation (Note 5)	Ta = +70°C	P_{D}	0.7	
Thermal Desistance Junction to Ambient (Note 5)	Steady State	C	106	°C/W
Thermal Resistance, Junction to Ambient (Note 5)	t < 10s	$R_{\theta JA}$	53	
Total Power Discinstion (Note 6)	Ta = +25°C	ם	2	W
Total Power Dissipation (Note 6)	Ta = +70°C	P _D	1.2	
Thermal Resistance, Junction to Ambient (Note 6)	Steady State	c	65	°C/W
	t < 10s	$R_{\theta JA}$	34	
Thermal Resistance, Junction to Case (Note 6)		R ₀ JC	9	°C/W
Operating and Storage Temperature Range		$T_{J,}T_{STG}$	-55 to +150	°C

Electrical Characteristics (@T_A = +25°C, unless otherwise specified.)

Characteristic	Symbol	Min	Тур	Max	Unit	Test Condition
OFF CHARACTERISTICS (Note 8)						
Drain-Source Breakdown Voltage	BV _{DSS}	60	_	_	V	$V_{GS} = 0V, I_D = 250\mu A$
Zero Gate Voltage Drain Current	I _{DSS}	_	_	1	μA	$V_{DS} = 60V$, $V_{GS} = 0V$
Gate-Source Leakage	I _{GSS}		_	±100	nA	$V_{GS} = \pm 20V, V_{DS} = 0V$
ON CHARACTERISTICS (Note 8)						
Gate Threshold Voltage	V _{GS(TH)}	1	_	3	V	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$
Static Drain-Source On-Resistance		_	30	40	mΩ	$V_{GS} = 10V, I_D = 12A$
Static Dialii-Source Off-Resistance	R _{DS(ON)}	_	35	55	11122	$V_{GS} = 4.5V, I_D = 6A$
Diode Forward Voltage	V_{SD}	_	0.7	1.2	V	$V_{GS} = 0V$, $I_S = 1A$
DYNAMIC CHARACTERISTICS (Note 9)						
Input Capacitance	C _{ISS}		1,287			$V_{DS} = 25V, V_{GS} = 0V$ f = 1.0MHz
Output Capacitance	Coss		57		pF	
Reverse Transfer Capacitance	C _{RSS}		44	_		
Gate Resistance	R_G	_	1.2	_	Ω	$V_{DS} = 0V, V_{GS} = 0V, f = 1.0MHz$
Total Gate Charge (V _{GS} = 10V)	Q_{G}	_	22.4	_		
Total Gate Charge (V _{GS} = 4.5V)	Q_{G}	_	10.4	_	nC	$V_{DS} = 30V, I_D = 4.3A$
Gate-Source Charge	Q _{GS}	_	4.9	_	nc	
Gate-Drain Charge	Q_{GD}	_	3.0	_		
Turn-On Delay Time	t _{D(ON)}	_	6.6	_		$V_{GS} = 10V, V_{DD} = 30V, R_G = 6\Omega,$ $I_D = 4.3A$
Turn-On Rise Time	t _R	_	8.1	_		
Turn-Off Delay Time	t _{D(OFF)}		20.1		ns	
Turn-Off Fall Time	t _F	_	4.0			
Body Diode Reverse Recovery Time	t _{RR}		18		ns	I _S = 4.3A, di/dt = 100A/μs
Body Diode Reverse Recovery Charge	Q_{RR}	_	11.9		nC	I _S = 4.3A, di/dt = 100A/μs

Notes: 5. Device mounted on FR-4 substrate PC board, 2oz copper, with minimum recommended pad layout.

Datasheet number: DS36106 Rev. 3 - 2

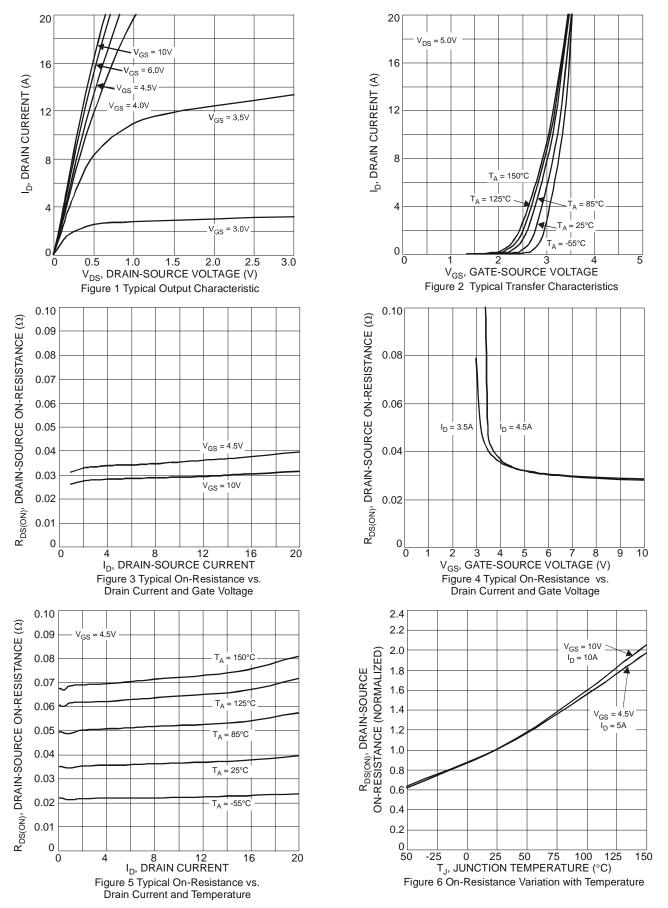
^{6.} Device mounted on FR-4 substrate PC board, 2oz copper, with thermal vias to bottom layer 1-inch square copper plate.

^{7.} I_{AS} and E_{AS} rating are based on low frequency and duty cycles to keep $T_J = +25$ °C.

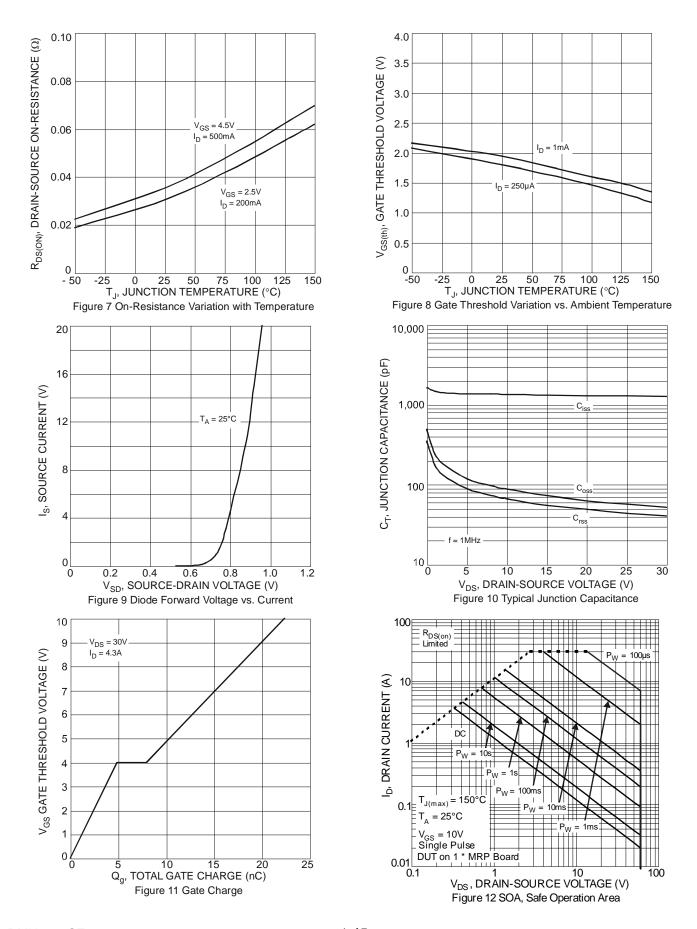
^{8.} Short duration pulse test used to minimize self-heating effect.

^{9.} Guaranteed by design. Not subject to product testing.

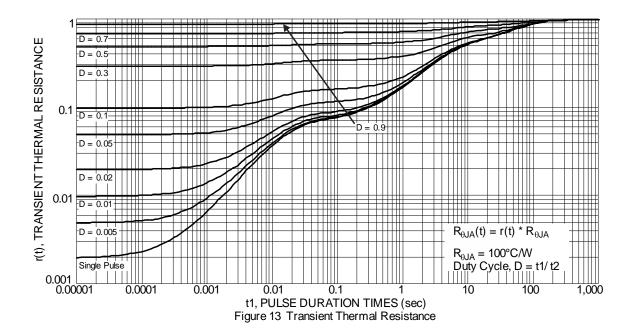








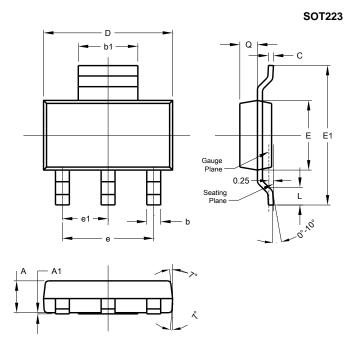






Package Outline Dimensions

Please see http://www.diodes.com/package-outlines.html for the latest version.

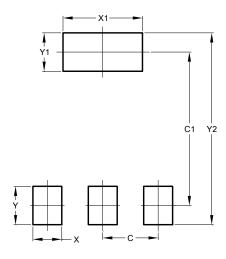


SOT223					
Dim	Min	Max	Тур		
Α	1.55	1.65	1.60		
A1	0.010	0.15	0.05		
b	0.60	0.80	0.70		
b1	2.90	3.10	3.00		
С	0.20	0.30	0.25		
D	6.45	6.55	6.50		
ш	3.45	3.55	3.50		
E1	6.90	7.10	7.00		
е	_	_	4.60		
e1	_	_	2.30		
L	0.85	1.05	0.95		
Ø	0.84	0.94	0.89		
All Dimensions in mm					

Suggested Pad Layout

Please see http://www.diodes.com/package-outlines.html for the latest version.

SOT223



Dimensions	Value (in mm)
С	2.30
C1	6.40
Х	1.20
X1	3.30
Y	1.60
Y1	1.60
Y2	8.00



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